

Environmental testing - Part 2-69: Tests - Test Te/Tc:  
Solderability testing of electronic components and  
printed boards by the wetting balance (force  
measurement) method

EESTI STANDARDI EESSÕNA

NATIONAL FOREWORD

See Eesti standard EVS-EN 60068-2-69:2017 sisaldab Euroopa standardi EN 60068-2-69:2017 ingliskeelset teksti.	This Estonian standard EVS-EN 60068-2-69:2017 consists of the English text of the European standard EN 60068-2-69:2017.
Standard on jõustunud sellekohase teate avaldamisega EVS Teatajas	This standard has been endorsed with a notification published in the official bulletin of the Estonian Centre for Standardisation.
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ICS 19.040, 31.190

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English Version

Environmental testing -  
Part 2-69: Tests - Test Te/Tc: Solderability testing of electronic  
components and printed boards by the wetting balance (force  
measurement) method  
(IEC 60068-2-69:2017)

Essais d'environnement -  
Partie 2-69: Essais - Essai Te/Tc: Essai de brasabilité des  
composants électroniques et cartes imprimées par la  
méthode de la balance de mouillage (mesure de la force)  
(IEC 60068-2-69:2017)

Umgebungseinflüsse - Teil 2-69: Prüfungen - Prüfung  
Te/Tc: Prüfung der Lötbarekeit von Bauelementen der  
Elektronik und Leiterplatten mit der Benetzungswaage  
(Kraftmessung)  
(IEC 60068-2-69:2017)

This European Standard was approved by CENELEC on 2017-04-11. CENELEC members are bound to comply with the CEN/CENELEC Internal Regulations which stipulate the conditions for giving this European Standard the status of a national standard without any alteration.

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European Committee for Electrotechnical Standardization  
Comité Européen de Normalisation Electrotechnique  
Europäisches Komitee für Elektrotechnische Normung

CEN-CENELEC Management Centre: Avenue Marnix 17, B-1000 Brussels

## European foreword

The text of document 91/1405/FDIS, future edition 3 of IEC 60068-2-69, prepared by IEC/TC 91 "Electronics assembly technology" was submitted to the IEC-CENELEC parallel vote and approved by CENELEC as EN 60068-2-69:2017.

The following dates are fixed:

- latest date by which the document has to be implemented at national level by publication of an identical national standard or by endorsement (dop) 2018-01-11
- latest date by which the national standards conflicting with the document have to be withdrawn (dow) 2020-04-11

This document supersedes EN 60068-2-69:2007 and EN 60068-2-54:2006.

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## Endorsement notice

The text of the International Standard IEC 60068-2-69:2017 was approved by CENELEC as a European Standard without any modification.

In the official version, for Bibliography, the following notes have to be added for the standards indicated:

IEC 60068-3-13:2016	NOTE	Harmonized as EN 60068-3-13:2016 (not modified).
IEC 61190-1-1:2002	NOTE	Harmonized as EN 61190-1-1:2002 (not modified).
ISO 9453:2014	NOTE	Harmonized as EN ISO 9453:2014 (not modified).

## Annex ZA (normative)

### **Normative references to international publications with their corresponding European publications**

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE 1 When an International Publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

NOTE 2 Up-to-date information on the latest versions of the European Standards listed in this annex is available here:  
[www.cenelec.eu](http://www.cenelec.eu)

<u>Publication</u>	<u>Year</u>	<u>Title</u>	<u>EN/HD</u>	<u>Year</u>
IEC 60068-1	-	Environmental testing - Part 1: General and guidance	EN 60068-1	-
IEC 60068-2-2	-	Environmental testing - Part 2-2: Tests - Test B: Dry heat	EN 60068-2-2	-
IEC 60068-2-20	2008	Environmental testing - Part 2-20: Tests - Test T: Test methods for solderability and resistance to soldering heat of devices with leads	EN 60068-2-20	2008
IEC 60068-2-66	-	Environmental testing - Part 2-66: Test methods - Test Cx: Damp heat, steady state (unsaturated pressurized vapour)	EN 60068-2-66	-
IEC 61190-1-3	2007	Attachment materials for electronic assembly - Part 1-3: Requirements for electronic grade solder alloys and fluxed and non-fluxed solid solders for electronic soldering applications	EN 61190-1-3	2007
+A1	2010		+A1	2010
ISO 683	Series	Heat treatable steels, alloy steels and free-cutting steels	EN ISO 683	Series <sup>1)</sup>
ISO 6362	Series	Wrought aluminium and aluminium alloys extruded rods/bars, tubes and profiles	-	-

<sup>1)</sup> At draft stage.

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